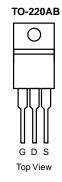


IRF4905PBF-VB Datasheet

P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY		
V _{DS}	-60	V
$R_{DS(on)}$ $V_{GS} = 10$ V	19	mΩ
$R_{DS(on)}$ $V_{GS} = 4.5$ V	26	mΩ
I _D	-50	А
Configuration	Sin	gle

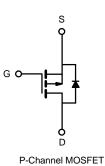


FEATURES

- TrenchFET[®] Power MOSFET
- 100 % UIS Tested

APPLICATIONS

· Load Switch





ABSOLUTE MAXIMUM RATINGS	(T _A = 25 °C, unle	ess otherwise no	ted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	- 60	V
Gate-Source Voltage		V _{GS}	± 20	v
	T _C = 25 °C		- 50	
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C		- 46	
Continuous Diain Current $(1) = 150$ C)	T _A = 25 °C	I _D	-39	•
	T _A = 70 °C		-34	A
Pulsed Drain Current	Pulsed Drain Current			
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	- 45	
Single Pulse Avalanche Energy	L = 0.1 IIIH	E _{AS}	101	mJ
Continuous Source-Drain Diode Current	T _C = 25 °C	L.	69 ^a	А
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	20 ^b	
	T _C = 25 °C		104.2 ^a	
	T _C = 70 °C		66.7 ^a	w
Maximum Power Dissipation	T _A = 25 °C	P _D	3.1 ^b	vv
	T _A = 70 °C		2 ^b	
Operating Junction and Storage Temperature Ra	inge	T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATING	5				
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	33	40	°C/W
Maximum Junction-to-Case	Steady State	R _{thJC}	0.98	1.2	0/00

Notes:

a. Based on $T_C = 25 \ ^{\circ}C$.

b. Surface mounted on 1" x 1" FR4 board.

Static Vis Vis Vis Vis Pis Pis	SPECIFICATIONS ($T_J = 25 \ ^{\circ}C$,	unless othe	erwise noted)				
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
	Static						
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = -250 \mu A$	- 60			V
	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L. – - 250 uA		68		m\//ºC
Gate-Source Leakage l_{QSS} $V_{DS} = 0$ $V_{QS} = 20$ ± 100 nA Zero Gate Voltage Drain Current l_{DSS} $V_{DS} = -60$ $V_{QS} = 0$ -1 μ A On-State Drain Current ^a $l_{D(on)}$ $V_{DS} = -60$ $V_{QS} = 0$ -10 A Drain-Source On-State Resistance ^a $R_{DS(on)}$ $V_{QS} = -10$ -120 A Forward Transconductance ^a g_{15} $V_{DS} = -50$ A 26 $m\Omega$ Multi Capacitance C_{isa} $V_{DS} = -15$ V, $I_D = -50$ A 20 S Dupt Capacitance C_{isa} $V_{DS} = -30$ V, $V_{GS} = -10$ V, $I_D = -55$ A 76 115 Reverse Transfer Capacitance C_{rss} $V_{DS} = -30$ V, $V_{GS} = -4.5$ V, $I_D = -55$ A 76 115 Gate Charge Q_{gd} $V_{DS} = -30$ V, $V_{GS} = -10$ V, $I_D = -55$ A 16 nC Gate Resistance R_g $f = 1$ MHz 5.2 Ω Ω Turn-Off Delay Time $I_d(on)$ $V_{DS} = -30$ V, $V_{GS} = -10$ V, $R_g = 1 \Omega$ 10 15	V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = - 200 μΛ		- 5.2		mv/ C
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1		- 3	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Leakage		$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Zana Oaka Malka na Dania Oanna at		$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1	μA
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gate Voltage Drain Current	DSS	V_{DS} = - 60 V, V_{GS} = 0 V, T_{J} = 55 °C			- 10	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 120			А
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source On-State Resistance ^a	Р	V _{GS} = - 10 V, I _D = - 30 A		19		
		RDS(on)	V _{GS} = - 4.5 V, I _D = - 20 A		26		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 50 A	20			S
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic ^b		· · · · · · · · · · · · · · · · · · ·		•	•	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Input Capacitance	C _{iss}			3700		
$ \begin{array}{c c c c c c c c } Total Gate Charge & Q_{g} & V_{DS} = -30 \ V, \ V_{GS} = -10 \ V, \ I_{D} = -55 \ A & 76 & 115 \\ \hline & & 38 & 60 \\ \hline & & & & & & & & & & & & & & & & & &$	Output Capacitance	C _{oss}	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		390		pF
$ \begin{array}{c c c c c c c c } Total Gate Charge & Q_{g} & V_{DS} = -30 \ V, \ V_{GS} = -10 \ V, \ I_{D} = -55 \ A & 76 & 115 \\ \hline & & 38 & 60 \\ \hline & & & & & & & & & & & & & & & & & &$	Reverse Transfer Capacitance	C _{rss}			290		
$ \begin{array}{ c c c c } \hline & & & & & & & & & & & & & & & & & & $	Total Cata Charge		$V_{DS} = -30$ V, $V_{GS} = -10$ V, $I_{D} = -55$ A		76	115	nC
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Total Gale Charge		٣ġ		38	60	
$ \begin{array}{c c c c c c c c c } \hline Gate Resistance & R_g & f = 1 \ MHz & 5.2 & \Omega \\ \hline Turn-On Delay Time & t_d(on) & \\ \hline Rise Time & t_r & \\ \hline Turn-Off Delay Time & t_d(off) & \\ \hline Turn-Off Delay Time & t_d(off) & \\ \hline Fall Time & t_f & \\ \hline \hline Drain-Source Body Diode Characteristics & \\ \hline Continuous Source-Drain Diode Current & I_S & T_C = 25 \ ^C & -69 & \\ \hline Pulse Diode Forward Current^a & I_{SM} & -150 & \\ \hline Body Diode Reverse Recovery Time & t_{rr} & \\ \hline Body Diode Reverse Recovery Charge & Q_{rr} & \\ \hline Reverse Recovery Fall Time & t_a & \\ \hline \end{array} $	Gate-Source Charge	Q _{gs}	V_{DS} = - 30 V, V_{GS} = - 4.5 V, I_{D} = - 55 A		16		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Drain Charge	Q _{gd}			19		
Rise Time t_r $V_{DD} = -2 V, R_L = 2 \Omega$ 7 15 nsTurn-Off Delay Time $t_d(off)$ $I_D \cong -10 A, V_{GEN} = -10 V, R_g = 1 \Omega$ 70 110 40 60 Fall Time t_f $10 \Omega A, V_{GEN} = -10 V, R_g = 1 \Omega$ 70 110 40 60 Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode Current I_S $T_C = 25 °C$ -69 A Pulse Diode Forward Current ^a I_{SM} -150 A Body Diode Voltage V_{SD} $I_S = -30 A$ -1 -1.5 V Body Diode Reverse Recovery Time t_{rr} $I_F = -50 A, di/dt = 100 A/\mu S, T_J = 25 °C$ 59 120 nC Reverse Recovery Fall Time t_a $I_F = -50 A, di/dt = 100 A/\mu S, T_J = 25 °C$ 59 120 nC	Gate Resistance	R _g	f = 1 MHz		5.2		Ω
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-On Delay Time	t _{d(on)}			10	15	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Rise Time	t _r	V_{DD} = - 2 V, R_L = 2 Ω		7	15	ns
Fall Time t_f 4060Drain-Source Body Diode Characteristics $T_C = 25 \ ^{\circ}C$ - 69AContinuous Source-Drain Diode CurrentIs $T_C = 25 \ ^{\circ}C$ - 69APulse Diode Forward Current ^a IsM- 150ABody Diode Voltage V_{SD} $I_S = - 30 \ ^{\circ}A$ - 1- 1.5VBody Diode Reverse Recovery Time t_{rr} 455 68nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = -50 \ ^{\circ}A$, di/dt = 100 $A/\mu s$, $T_J = 25 \ ^{\circ}C$ 29nc	Turn-Off Delay Time	t _{d(off)}	$I_{D}\cong$ - 10 A, V_{GEN} = - 10 V, R_{g} = 1 Ω		70	110	
Continuous Source-Drain Diode CurrentIs $T_C = 25 \ ^{\circ}C$ - 69APulse Diode Forward Current ^a IsM- 150- 150Body Diode Voltage V_{SD} $I_S = -30 \ A$ - 1- 1.5VBody Diode Reverse Recovery Time t_{rr} 4568nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = -50 \ A, di/dt = 100 \ A/\mus, T_J = 25 \ ^{\circ}C$ 29nc	Fall Time				40	60	
Pulse Diode Forward Current ^a I SM- 150ABody Diode Voltage V_{SD} $I_S = -30 \text{ A}$ - 1- 1.5VBody Diode Reverse Recovery Time t_{rr} 4568nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = -50 \text{ A}, di/dt = 100 \text{ A/µs}, T_J = 25 °C$ 59120nCReverse Recovery Fall Time t_a rr rr rr rr rr rr	Drain-Source Body Diode Characteristic	s	1		1	1	1
Pulse Diode Forward Current ^a I_{SM} - 150Body Diode Voltage V_{SD} $I_S = -30 \text{ A}$ - 1- 1.5VBody Diode Reverse Recovery Time t_{rr} 4568nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = -50 \text{ A}$, di/dt = 100 A/µs, $T_J = 25 \text{ °C}$ 59120nCReverse Recovery Fall Time t_a rr rr rr rr rr	Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 69	•
Body Diode Reverse Recovery Time t_{rr} 4568nsBody Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a	Pulse Diode Forward Current ^a	I _{SM}				- 150	A
Body Diode Reverse Recovery Charge Q_{rr} IF = - 50 A, di/dt = 100 A/µs, TJ = 25 °C59120nCReverse Recovery Fall Time t_a	Body Diode Voltage	V _{SD}	I _S = - 30 A		- 1	- 1.5	V
Reverse Recovery Fall Time t_a $I_F = -50 \text{ A}, dl/dt = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ C}$ 29 ns	Body Diode Reverse Recovery Time	t _{rr}			45	68	ns
Reverse Recovery Fall Time t_a $I_F = -50 \text{ A}, dl/dt = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ C}$ 29 ns	Body Diode Reverse Recovery Charge	Q _{rr}			59	120	nC
ns ns	Reverse Recovery Fall Time		$r_F = -50$ A, al/at = 100 A/µs, $r_J = 25$ °C		29		
	Reverse Recovery Rise Time		1		16	ĺ	ns

Notes:

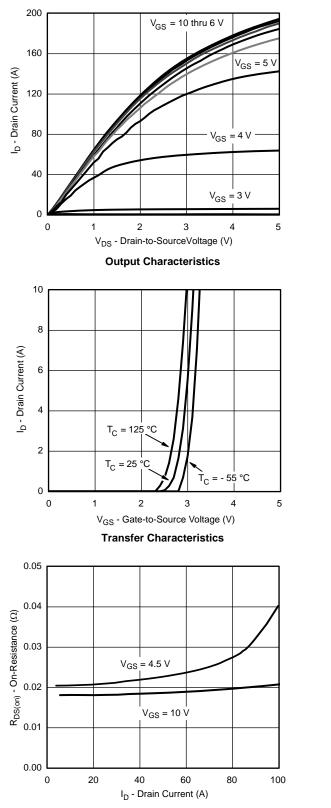
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

emi

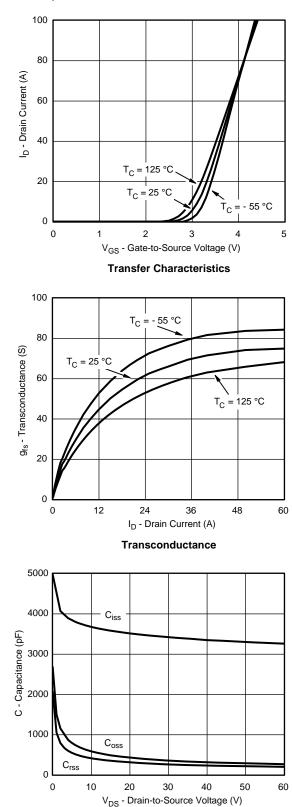
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

On-Resistance vs. Drain Current



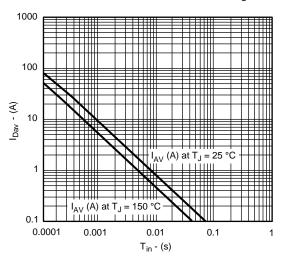
Capacitance



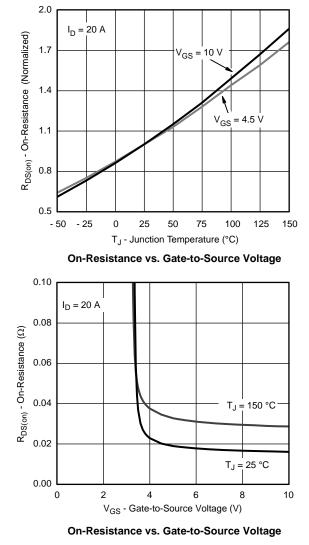
10 I_D = 55 A V_{GS} - Gate-to-Source Voltage (V) 8 V_{DS} = 20 V 6 $V_{DS} = 30 V$ 4 2 0 0 20 40 60 80 Q_q - Total Gate Charge (nC) Gate Charge 100 I_S - Source Current (A) T_J = 150 °C T_J = 25 °C 10 1 0.0 0.3 0.6 0.9 1.2 V_{SD} - Source-to-Drain Voltage (V)

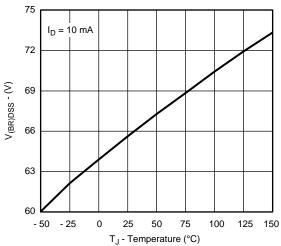
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Source-Drain Diode Forward Voltage



Single Pulse Avalanche Current Capability vs. Time

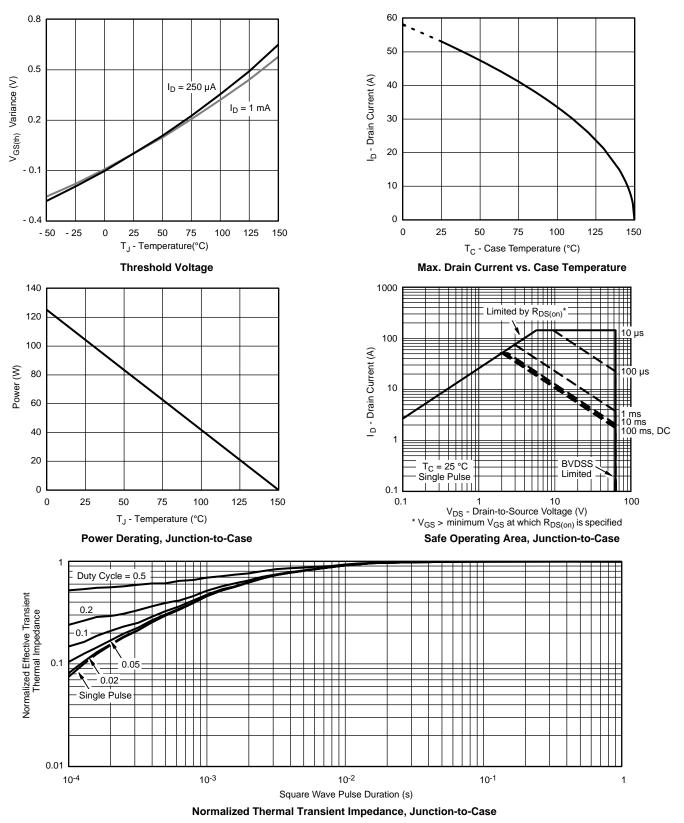




Drain-Source Breakdown Voltage vs. Junction Temperature

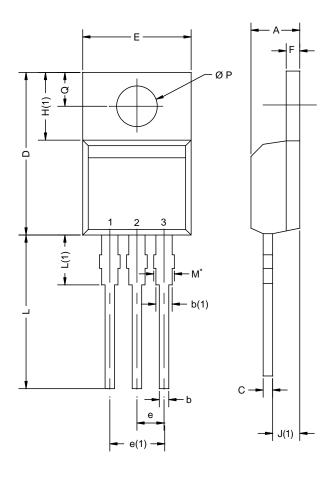


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





TO-220AB



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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